

<b>Issue Classification</b>				Application/Control No.		Applicant(s)/Patent under Reexamination	
				10/764,283		CHAPMAN, THOMAS R.	
				Examiner		Art Unit	
				Devin Hanan		3745	

ORIGINAL				CROSS REFERENCE(S)								
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)									
416	185	415	206									
INTERNATIONAL CLASSIFICATION												
F	O	1	D	5/22								
				/								
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<i>Devin Hanan 4/14/2006</i> Devin Hanan 4/14/2006 (Assistant Examiner) (Date)				<i>Edward K. Look 4/17/06</i> EDWARD K. LOOK SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 3700 (Primary Examiner) (Date)				Total Claims Allowed: 35				
<i>K. Cooper 4/20/06</i> K. Cooper 4/20/06 (Legal Instruments Examiner) (Date)								O.G. Print Claim(s)		O.G. Print Fig.		
								1		2		

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
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